

Broduct data sheet

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MSK100N03DF

Compiance

Description

The MSK100N03DF uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and

operation with gate voltages as low as 4.5V. This

device is suitable for use as a

Battery protection or in other Switching application.

General Features

VDS = 30V ID =100A

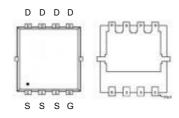
 $R_{DS(ON)} < 4 \text{ m}\Omega @ V_{GS}=10V$

Application

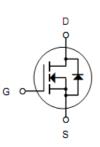
Battery protection

Load switch

Uninterruptible power supply



DFN3X3-8L



N-Channel MOSFET

Absolute Maximum Ratings (TC=25°C unless otherwise specified)

Symbol	Parameter	Rating	Units	
Vds	Drain-Source Voltage	30	V	
Vgs	Gate-Source Voltage	Gate-Source Voltage ±20		
I⊳@Tc=25°C	Continuous Drain Current, V _{GS} @ 10V ¹	100	А	
I⊳@Tc=100°C	Continuous Drain Current, V _{GS} @ 10V ¹	70	А	
Ib@Ta=25°C	Continuous Drain Current, V _{GS} @ 10V ¹	30	Α	
I⊳@T _A =70°C	Continuous Drain Current, V _{GS} @ 10V ¹	25	Α	
Ідм	Pulsed Drain Current ²	192	Α	
EAS	Single Pulse Avalanche Energy ³	144.7	mJ	
las	Avalanche Current	53.8	А	
P₀@Tc=25°C	Total Power Dissipation ⁴	62.5	W	
PD@Ta=25°C	Total Power Dissipation ⁴	4.5	W	
Тятс	Storage Temperature Range	-55 to 150	°C	
TJ	Operating Junction Temperature Range	-55 to 150	°C	
Reja	Thermal Resistance Junction-ambient ¹	62	°C/W	
Rejc	Thermal Resistance Junction-Case ¹	2.4	°C/W	



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Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30			V
∆BVdss/∆Tj	BVDSS Temperature Coefficient	Reference to 25°C, I _D =1mA		0.0213		V/°C
		Vgs=10V , Id=30A		3.4	4	
Rds(ON)	Static Drain-Source On- Resistance ²	Vgs=4.5V,Id=15A		5.2	6	mΩ
VGS(th)	Gate Threshold Voltage		1.0		2.5	V
ΔV GS(th)	VGS(th) Temperature Coefficient	Vgs=Vbs,Ib =250uA		-5.8		mV/°C
		V _{DS} =24V , V _{GS} =0V , T _J =25°C			1	
loss		Drain-Source Leakage Current V _{DS} =24V , V _{GS} =0V , T _J =55°C			5	uA
lgss	Gate-Source Leakage Current	Vgs=±20V , Vds=0V			±100	nA
gfs	Forward Transconductance	Vds=5V , Id=30A		26.5		S
Rg	Gate Resistance	V _{DS} =0V,V _{GS} =0V, f=1MHz		1.4		Ω
Qg	Total Gate Charge (4.5V)			31.6		
Qgs	Gate-Source Charge	VDS=15V, VGS=4.5V,		8.6		nC
Qgd	Gate-Drain Charge	_ I ⊳=15A		11.7		
Td(on)	Turn-On Delay Time			9		
Tr	Rise Time	Vdd=15V, Vgs=10V,		19		
Td(off)	Turn-Off Delay Time	$-R_{G}=3.3\Omega$		58		ns
Tf	Fall Time	_ ID=15A		15.2		
Ciss	Input Capacitance			3075		
Coss	Output Capacitance	VDS=15V , VGS=0V ,		400		pF
Crss	Reverse Transfer Capacitance	_f=1MHz		315		
ls	Continuous Source Current1,6	V _G =V _D =0V , Force			100	Α
lsм	Pulsed Source Current _{2,6}	Current			192	Α
Vsd	Diode Forward Voltage ²	V _{GS} =0V,Is=1A, TJ=25°C			1	V

Electrical Characteristics (T=25°C, unless otherwise noted)

Diode Characteristics

Note :

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

2.The data tested by pulsed , pulse width \leq 300us , duty cycle $\leq 2\%$

 $3\,$.The EAS data shows Max. rating . The test condition is V_DD=25V,V_GS=10V,L=0.1mH,I_{AS}=34A 4.The power dissipation is limited by 150°C junction temperature

5 .The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



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Typical Characteristics

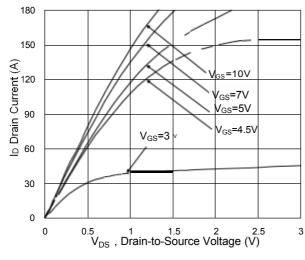


Fig.1 Typical Output Characteristics

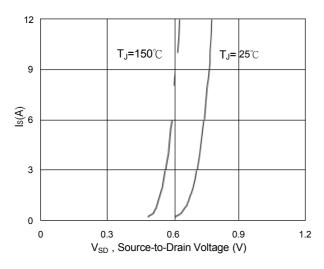


Fig.3 Forward Characteristics of Reverse

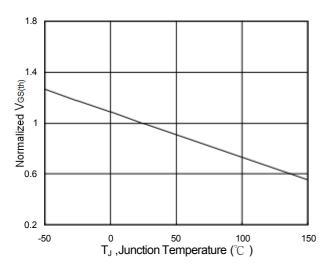


Fig.5 Normalized VGS(th) vs. TJ

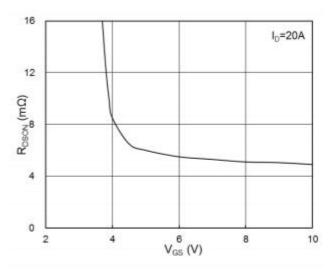


Fig.2 On-Resistance vs. G-S Voltage

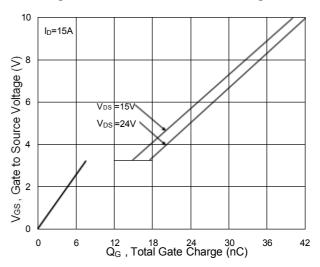


Fig.4 Gate-Charge Characteristics

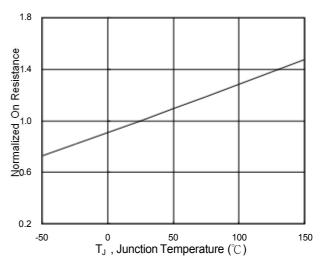


Fig.6 Normalized RDSON vs. TJ



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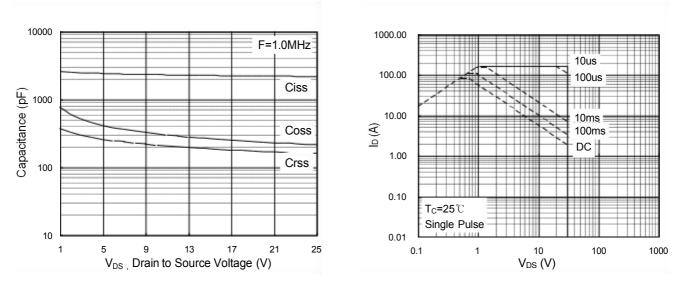


Fig.7 Capacitance

Fig.8 Safe Operating Area

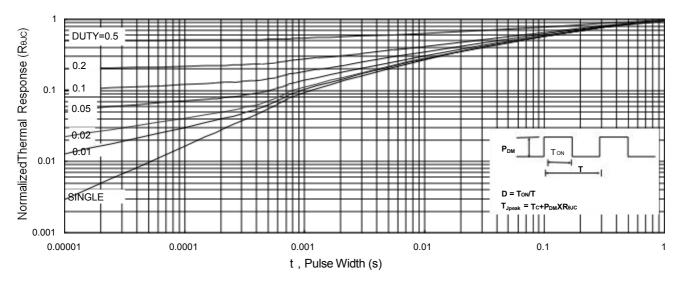
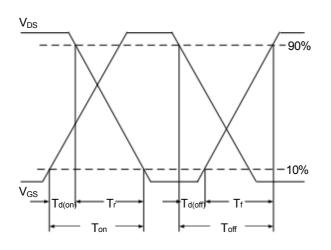
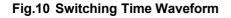


Fig.9 Normalized Maximum Transient Thermal Impedance





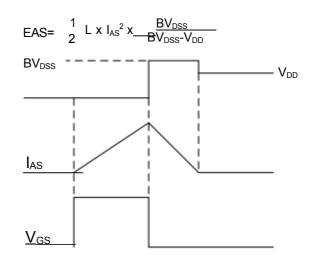


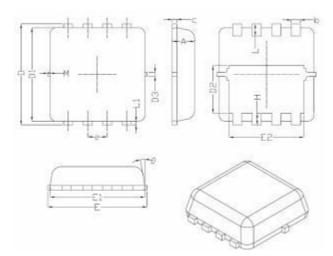
Fig.11 Unclamped Inductive Switching Waveform





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DFN3X3-8L Package Information



Symbol	Dimensions In Millimeters			
	Min.	Nom.	Max.	
A	0.70	0.75	0.80	
b	0.25	0.30	0.35	
С	0.10	0.15	0.25	
D	3.25	3.35	3.45	
D1	3.00	3.10	3.20	
D2	1.48	1.58	1.68	
D3	-	0.13	-	
E	3.20	3.30	3.40	
E1	3.00	3.15	3.20	
E2	2.39	2.49	2.59	
е	0.6	5BSC		
Н	0.30	0.39	0.50	
L	0.30	0.40	0.50	
L1	-	0.13	-	
М	*	*	0.15	
θ		10 [°]	12 [°]	

REEL SPECIFICATION

P/N	PKG	QTY
MSK100N03DF	DFN3X3-8L	5000



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